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INTERNATIONAL
STANDARD
NORME
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Field Device Integration (FDI) –
Part 101-2: Profiles – Foundation Fieldbus HSE

Intégration des appareils de terrain (FDI) –
Partie 101-2: Profils – Foundation Fieldbus HSE





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The text of this standard is based on the following documents:

CDV	Report on voting
65E/353/CDV	65E/416/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 62769 series, published under the general title *Field Device Integration (FDI)*, can be found on the IEC website.

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- b) Method and device for accessing a functional module of automation system, see Patent Family EP2182418;
- c) Methods and apparatus to reduce memory requirements for process control system software applications, see Patent Family US2013232186 ;
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FIELD DEVICE INTEGRATION (FDI) –

Part 101-2: Profiles – Foundation Fieldbus HSE

1 Scope

This part of IEC 62769 specifies the IEC 62769 profile for IEC 61784-1, CP 1/2 (FOUNDATION™ Fieldbus HSE)¹.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 61784-1, *Industrial communication networks - Profiles - Part 1: Fieldbus profiles*

IEC 61784-2, *Industrial communication networks - Profiles - Part 2: Additional fieldbus profiles for real-time networks based on ISO/IEC 8802-3*

IEC 61804 (all parts), *Function blocks (FB) for process control*

IEC 62541-100:2015, *OPC Unified Architecture – Part 100: Device interface*

IEC 62769-2, *Field Device Integration (FDI) – Part 2: FDI Client*

NOTE IEC 62769-2 is technically identical to FDI-2022.

IEC 62769-3, *Field Device Integration (FDI) – Part 3: FDI Server*

NOTE IEC 62769-3 is technically identical to FDI-2023.

IEC 62769-4, *Field Device Integration (FDI) – Part 4: FDI Packages*

NOTE IEC 62769-4 is technical identically to FDI-2024.

IEC 62769-5, *Field Device Integration (FDI) – Part 5: FDI Information Model*

NOTE IEC 62769-5 is technical identically to FDI-2025.

IEC 62769-6, *Field Device Integration (FDI) – Part 6: FDI Technology Mapping*

NOTE IEC 62769-6 is technical identically to FDI-2026.

IEC 62769-7, *Field Device Integration (FDI) – Part 7: FDI Communication Devices*

NOTE IEC 62769-7 is technical identically to FDI-2027.

¹ FOUNDATION™ Fieldbus is the trade name of the non-profit consortium Fieldbus Foundation. This information is given for the convenience of users of this technical report and does not constitute an endorsement by IEC of the trademark holder or any of its products. Compliance does not require use of the trade name. Use of the trade name requires permission of the trade name holder.

IEC 62769-101-1, *Field Device Integration (FDI) – Part 101-1: Profiles – Foundation Fieldbus H1*

3 Terms, definitions, abbreviated terms and acronyms

3.1 Terms and definitions

For the purposes of this document, the terms and definitions given in IEC 61784-1, IEC 61784-2, IEC 61804, IEC 62541-100, IEC 62769-2, IEC 62769-3, IEC 62769-4, IEC 62769-5, IEC 62769-6, IEC 62769-7 and IEC 62769-101-1 apply.

3.2 Abbreviated terms and acronyms

For the purposes of this document, the following abbreviations apply:

CFF	Common File format
CP	communication profile (see IEC 61784-1 or IEC 61784-2)
CPF	communication profile family (see IEC 61784-1 or IEC 61784-2)
EDD	Electronic Device Description (see IEC 61804 series)
FB	function block
IM	Information Model
SMIB	system management information base
VFD	virtual field device

4 Conventions

4.1 EDDL syntax

This part of IEC 62769 specifies content for the EDD component that is part of FDI Communication Packages. EDDL syntax uses the font Courier New. EDDL syntax is used for method signature, variable, data structure and component declarations.

4.2 XML syntax

XML syntax examples use the font Courier New. The XML syntax is used to describe XML document schema.

EXAMPLE: <xsd:simpleType name="Example">

5 Profile for CP 1/2 (FOUNDATION™ HSE)

5.1 General

This profile annex specifies the protocol specifics needed for FDI Packages describing communication servers, gateways and devices.

5.2 Catalog profile

5.2.1 Protocol support files

5.2.1.1 Capability file

Each CP 1/2 FDI Device Package shall contain a capability file. The capability file part is described in Table 1.